

Notice of References Cited

Application/Control No.	Applicant(s)/Pate	nt Under	
09/668,999	Reexamination BRODSKY ET AL	L.	
Examiner	Art Unit		
Dana Farahani	2814	Page 1 of 1	

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.